

CHAPTER OVERVIEW

9: Surface Morphology and Structure

9.1: Interferometry

9.2: Atomic Force Microscopy (AFM)

9.3: SEM and its Applications for Polymer Science

9.4: Catalyst Characterization Using Thermal Conductivity Detector

9.5: Nanoparticle Deposition Studies Using a Quartz Crystal Microbalance

Template:HideTOC

This page titled [9: Surface Morphology and Structure](#) is shared under a [CC BY 4.0](#) license and was authored, remixed, and/or curated by [Pavan M. V. Raja & Andrew R. Barron \(OpenStax CNX\)](#) via [source content](#) that was edited to the style and standards of the LibreTexts platform.